RENESAS
Renesas Technology Corp.

M5M5W817KT - 70HI

8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

DESCRIPTION

The M5M5W817KT is a family of low voltage 8Mbit static RAMs organized as 524288-words by 16-bit / 1048576-words by 8-bit, fabricated by Mitsubishi's high-performance 0.18μm CMOS technology.

The M5M5W817KT is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

The M5M5W817KT is packaged in a 52pin-μTSOP with the outline of 10.79mm x 10.49mm, and pin pitch of 0.40mm. It gives the best solution for a compaction of mounting area as well as flexibility of wiring pattern of printed circuit boards.

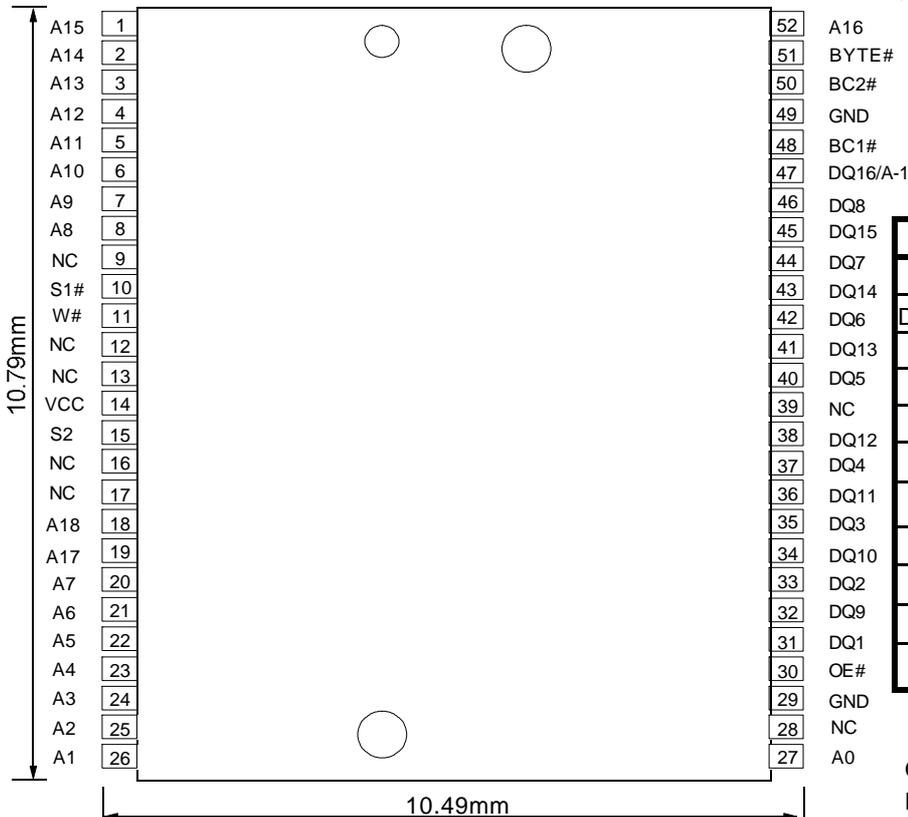The operating temperature range is -40 ~ +85°C

FEATURES

- Single 2.7~3.6V power supply
- Small stand-by current: 0.1μA (2.0V, typ.)
- No clocks, No refresh
- Data retention supply voltage =2.0~3.6V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S1#, S2, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE prevents data contention in the I/O bus
- Byte function (x8 mode) available by Byte# & A-1.
- Process technology: 0.18μm CMOS
- Package: 52pin 10.79mm x 10.49mm μTSOP
  [0.4mm pin pitch]

Operating temperature	Part name	Power Supply	Access time max.	Stand-by current						Active current Icc1 (3.3V, Typ.)
				* Typical		Ratings (max.)				
				25ºC	40ºC	25ºC	40ºC	70ºC	85ºC	
-40 ~ +85°C	M5M5W817KT -70HI	2.7 ~ 3.6V	70ns	1.0	1.2	5	8	20	40	30mA (10MHz) 5mA (1MHz)

PIN CONFIGURATION

* Typical parameter indicates the value for the center of distribution, and not 100% tested.

Pin	Left		Pin	Right
A15	1		52	A16
A14	2		51	BYTE#
A13	3		50	BC2#
A12	4		49	GND
A11	5		48	BC1#
A10	6		47	DQ16/A-1
A9	7		46	DQ8
A8	8		45	DQ15
NC	9		44	DQ7
S1#	10		43	DQ14
W#	11		42	DQ6
NC	12		41	DQ13
NC	13		40	DQ5
VCC	14		39	NC
S2	15		38	DQ12
NC	16		37	DQ4
NC	17		36	DQ11
A18	18		35	DQ3
A17	19		34	DQ10
A7	20		33	DQ2
A6	21		32	DQ9
A5	22		31	DQ1
A4	23		30	OE#
A3	24		29	GND
A2	25		28	NC
A1	26		27	A0

10.79mm

10.49mm

Pin	Function
A0 ~ A18	Address input
DQ1 ~ DQ16	Data input / output
S1#	Chip select input 1
S2	Chip select input 2
W#	Write control input
OE#	Output enable input
BC1#	Lower Byte (DQ1 ~ 8)
BC2#	Upper Byte (DQ9 ~ 16)
BYTE#	Byte (x8 mode) enable input
Vcc	Power supply
GND	Ground supply

Outline: 52PTG-A
N C : No Connection

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FUNCTION

The M5M5W817KT is organized as 524288-words by 16-bit / 1048576-words by 8-bit. These devices operate on a single +2.7~3.6V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1# , BC2# , S1#, S2 , W#, OE# and BYTE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S1# and the high level S2. The address (A-1~A18 : Byte mode, A0~A18 : Word mode) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S1#and S2 are in an active state (S1#=L, S2=H).

When setting BYTE# at a low level, the function will be in the x8 mede, which is, DQ1-8 are available and DQ9-16 are not available. In the x8 mode, A-1 is used as the additional address. During the active function for x8 mode, BC1# BC2# must be low level.

When setting BC1# and BC2# at a high level or S1# at a high level or S2 at a low level, the chips are in a non-selectable mode in which both reading and writing are disabled.

In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S1#, S2.

The power supply current is reduced as low as 0.1µA (25°C, typical), and the memory data can be held at +2.0V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

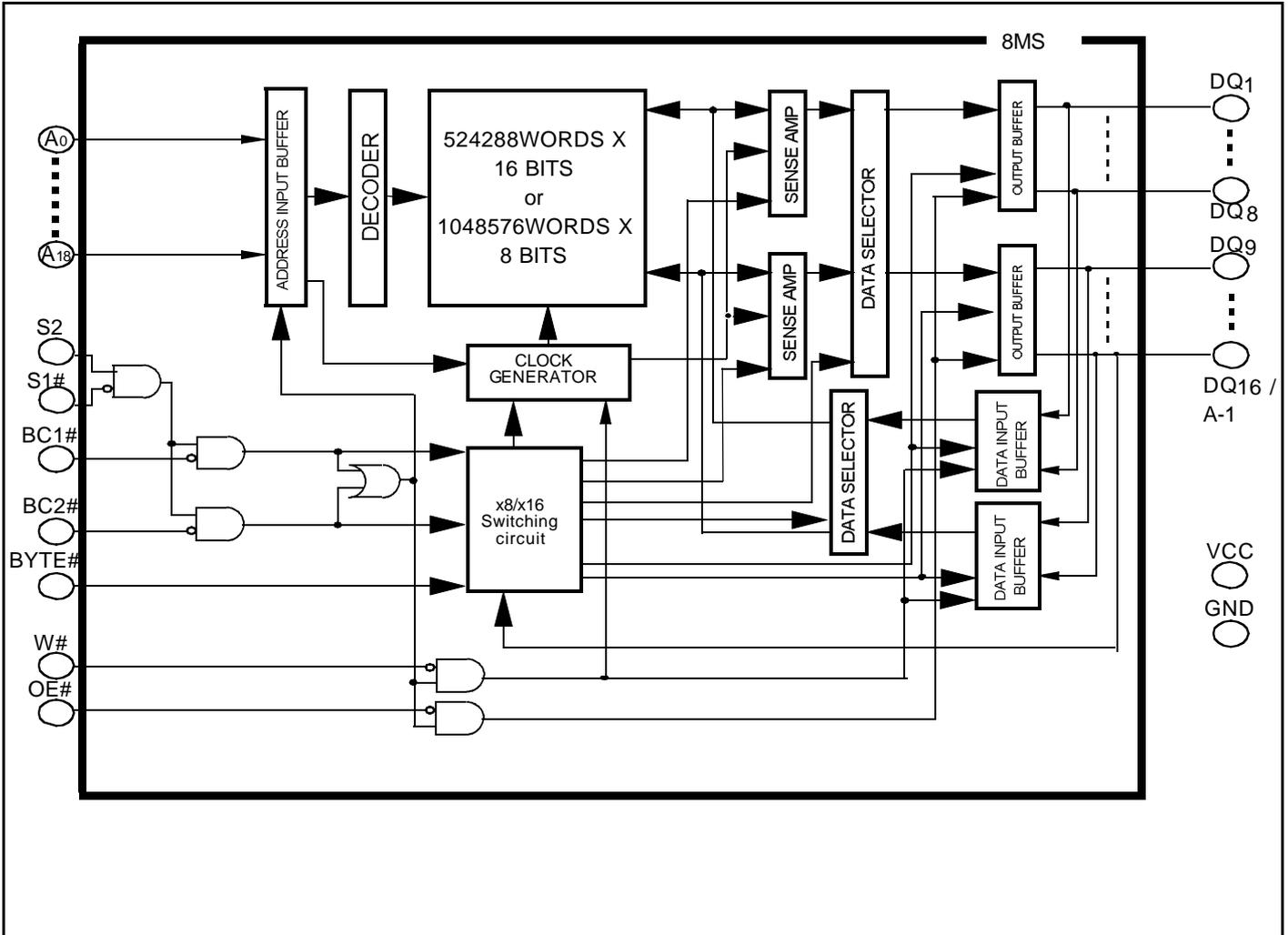| S1#	S2	BYTE#	BC1#	BC2#	W#	OE#	Mode	DQ1~8	DQ9~15	DQ16	Icc
H	H	H or L	X	X	X	X	Non selection	High-Z	High-Z	High-Z	Standby
X	L	H or L	X	X	X	X	Non selection	High-Z	High-Z	High-Z	Standby
X	X	H	H	H	X	X	Non selection	High-Z	High-Z	High-Z	Standby
L	H	H	L	H	L	X	Write	Din	High-Z	High-Z	Active
L	H	H	L	H	H	L	Read	Dout	High-Z	High-Z	Active
L	H	H	L	H	H	H	-------	High-Z	High-Z	High-Z	Active
L	H	H	H	L	L	X	Write	High-Z	Din	Din	Active
L	H	H	H	L	H	L	Read	High-Z	Dout	Dout	Active
L	H	H	H	L	H	X	-------	High-Z	High-Z	High-Z	Active
L	H	H	L	L	L	X	Write	Din	Din	Din	Active
L	H	H	L	L	H	L	Read	Dout	Dout	Dout	Active
L	H	H	L	L	H	X	-------	High-Z	High-Z	High-Z	Active
L	H	L	L	L	L	X	Write	Din	High-Z	A-1	Active
L	H	L	L	L	H	L	Read	Dout	High-Z	A-1	Active
L	H	L	L	L	H	H	-------	High-Z	High-Z	A-1	Active

Note1 : "H" and "L" in this table mean V_{IH} and V_{IL}, respectively.
Note2 : "X" in this table should be "H" or "L".

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BLOCK DIAGRAM

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ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Units
V_{CC}	Supply voltage	With respect to GND	- 0.3* ~ +4.6	
V_I	Input voltage	With respect to GND	- 0.3* ~ Vcc + 0.3 (max. 4.6V)	V
V_O	Output voltage	With respect to GND	0 ~ Vcc	
P_d	Power dissipation	Ta = 25°C	700	mW
T_a	Operating temperature		-40 ~ +85	ºC
T_{stg}	Storage temperature		- 65 ~ +150	ºC

* -3.0V in case of AC (Pulse width $\leq$ 30ns)

DC ELECTRICAL CHARACTERISTICS (Ta=-40~85ºC Vcc=2.7V~3.6V,unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
V_{IH}	High-level input voltage			2.2		Vcc+0.2V	V
V_{IL}	Low-level input voltage			- 0.2 *		0.6	V
V_{OH}	High-level output voltage	I_{OH}= - 0.5mA		2.4			V
V_{OL}	Low-level output voltage	I_{OL}= 2.0mA				0.4	V
I_I	Input leakage current	V_I =0 ~ Vcc				±1	µA
I_O	Output leakage current	BC1# and BC2#=VIH or S1#=VIH or S2=VIL or OE#=VIH, VI/O=0 ~ Vcc				±1	µA
I_{cc1}	Active supply current (AC,MOS level)	BC1# and BC2# $\leq$ 0.2V, S1# $\leq$ 0.2V, S2 $\geq$Vcc-0.2V other inputs $\leq$ 0.2V or $\geq$ Vcc-0.2V Output - open (duty 100%)	f= 10MHz	-	30	50	mA
			f= 1MHz	-	5	15	
I_{cc2}	Active supply current (AC,TTL level)	BC1# and BC2#=VIL , S1#=VIL ,S2=VIH other pins =VIH or VIL Output - open (duty 100%)	f= 10MHz	-	30	50	mA
			f= 1MHz	-	5	15	
I_{cc3}	Stand by supply current (AC,MOS level)	(1)S1# $\geq$ Vcc - 0.2V and S2 $\geq$ Vcc - 0.2V, BYTE# $\geq$ Vcc - 0.2V or $\leq$ 0.2V, other inputs = 0 ~ Vcc (2)S2 $\leq$ 0.2V, BYTE# $\geq$ Vcc - 0.2V or $\leq$ 0.2V, other inputs = 0 ~ Vcc (3) BC1# and BC2# $\geq$ Vcc - 0.2V S1# $\leq$ 0.2V, S2 $\geq$ Vcc - 0.2V BYTE# $\geq$ Vcc - 0.2V or $\leq$ 0.2V, other inputs = 0 ~ Vcc	~ +25°C	-	1.0	5	µA
			~ +40°C	-	1.2	8	
			~ +70°C	-	-	20	
			~ +85°C	-	-	40	
I_{cc4}	Stand by supply current (AC,TTL level)	BC1# and BC2# =VIH or S1# =VIH or S2=VIL BYTE# $\geq$ Vcc - 0.2V or $\leq$ 0.2V, Other inputs= 0 ~ Vcc		-	-	2.0	mA

* -1.0V in case of AC (Pulse width $\leq$ 30ns)

Note 3: Direction for current flowing into IC is indicated as positive (no mark)
Note 4: Typical parameter indicates the value for the center of distribution at 3.0V, and not 100% tested.

CAPACITANCE (Ta=-40~+85ºC Vcc=2.7V~3.6V,unless otherwise noted)

| Symbol	Parameter	Conditions	Min	Typ	Max	Units
C_I	Input capacitance	V_I=GND, V_I=25mVrms, f =1MHz			10	pF
C_O	Output capacitance	V_O=GND, V_O=25mVrms, f =1MHz			10	

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AC ELECTRICAL CHARACTERISTICS (Ta=-40~+85ºC, Vcc=2.7V~3.6V,unless otherwise noted)

(1) TEST CONDITIONS

Supply voltage	2.7~3.6V
Input pulse	V_{IH}=2.7V, V_{IL}=0.2V
Input rise time and fall time	5ns
Reference level	$V_{OH}=V_{OL}$=1.5V Transition is measured ±200mV from steady state voltage.(for ten,tdis)
Output loads	Fig.1,CL=30pF CL=5pF (for ten,tdis)

1TTL

DQ

CL

Including scope and jig capacitance

Fig.1 Output load
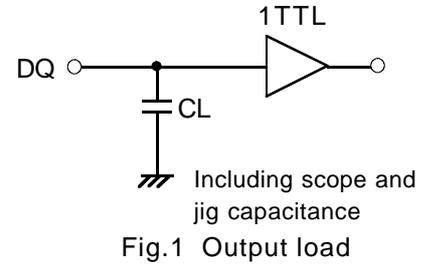
(2) READ CYCLE

Symbol	Parameter	Limits 70HI Min	Limits 70HI Max	Units
t_{CR}	Read cycle time	70		ns
$t_a(A)$	Address access time		70	ns
$t_a(S1)$	Chip select 1 access time		70	ns
$t_a(S2)$	Chip select 2 access time		70	ns
$t_a(BC1)$	Byte control 1 access time		70	ns
$t_a(BC2)$	Byte control 2 access time		70	ns
$t_a(OE)$	Output enable access time		35	ns
$t_{dis}(S1)$	Output disable time after S1# high		25	ns
$t_{dis}(S2)$	Output disable time after S2 low		25	ns
$t_{dis}(BC1)$	Output disable time after BC1# high		25	ns
$t_{dis}(BC2)$	Output disable time after BC2# high		25	ns
$t_{dis}(OE)$	Output disable time after OE# high		25	ns
$t_{en}(S1)$	Output enable time after S1# low	10		ns
$t_{en}(S2)$	Output enable time after S2 high	10		ns
$t_{en}(BC1)$	Output enable time after BC1# low	5		ns
$t_{en}(BC2)$	Output enable time after BC2# low	5		ns
$t_{en}(OE)$	Output enable time after OE# low	5		ns
$t_V(A)$	Data valid time after address	10		ns

(3) WRITE CYCLE

| Symbol	Parameter	Limits 70HI Min	Limits 70HI Max	Units
t_{CW}	Write cycle time	70		ns
$t_w(W)$	Write pulse width	55		ns
$t_{su}(A)$	Address setup time	0		ns
$t_{su}(A-WH)$	Address setup time with respect to W#	65		ns
$t_{su}(BC1)$	Byte control 1 setup time	65		ns
$t_{su}(BC2)$	Byte control 2 setup time	65		ns
$t_{su}(S1)$	Chip select 1 setup time	65		ns
$t_{su}(S2)$	Chip select 2 setup time	65		ns
$t_{su}(D)$	Data setup time	35		ns
$t_h(D)$	Data hold time	0		ns
$t_{rec}(W)$	Write recovery time	0		ns
$t_{dis}(W)$	Output disable time from W# low		25	ns
$t_{dis}(OE)$	Output disable time from OE# high		25	ns
$t_{en}(W)$	Output enable time from W# high	5		ns
$t_{en}(OE)$	Output enable time from OE# low	5		ns

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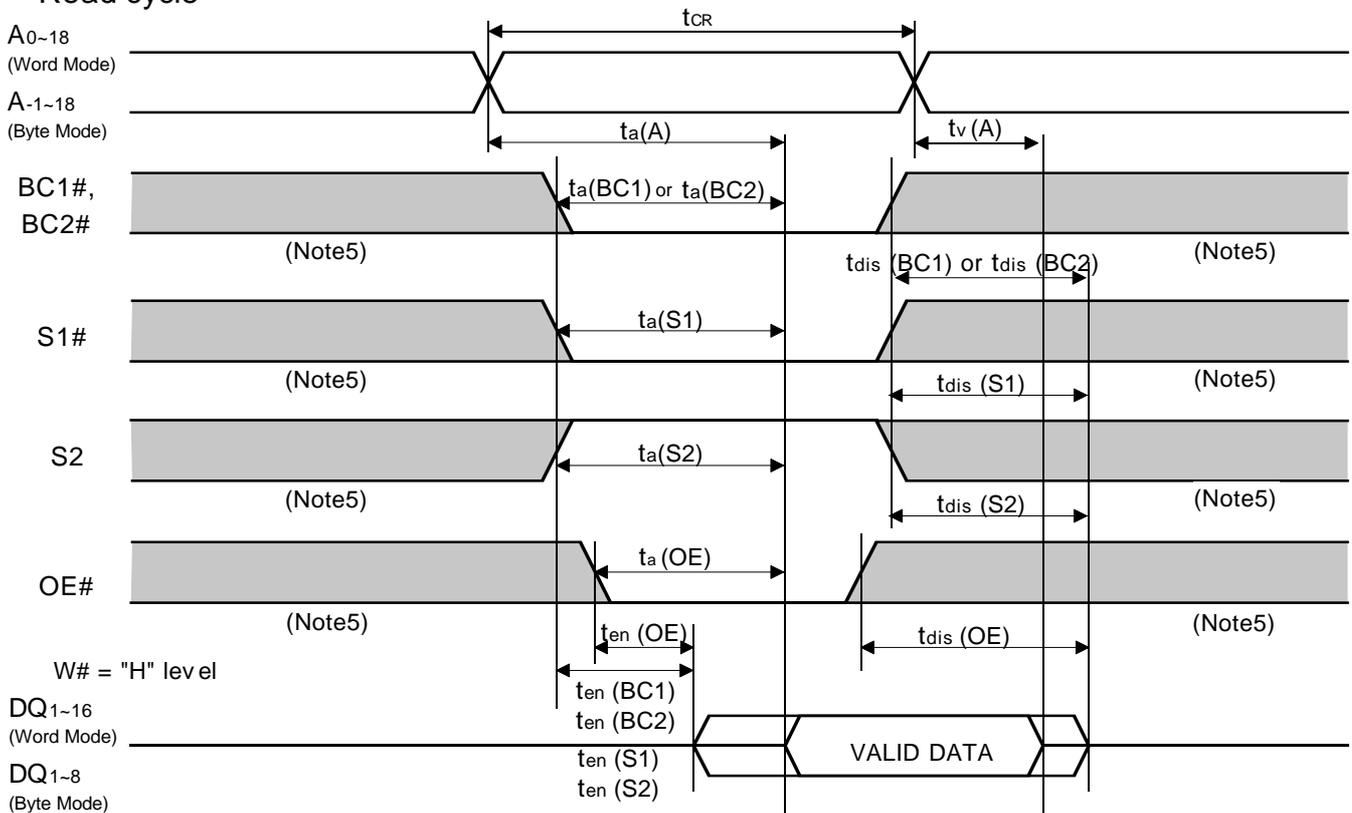
(4) Byte# function

Symbol	Parameter	Test conditions	Limits			Units
			Min	Typ	Max	
$t_{su\ (BYTE)}$	BYTE# set up time		5			ms
$t_{rec\ (BYTE)}$	BYTE# recovery time		5			ms

(5) TIMING DIAGRAMS

BYTE#
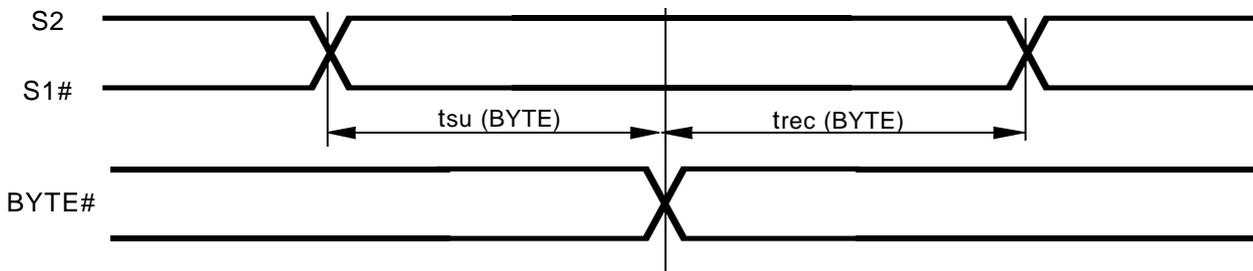
Read cycle

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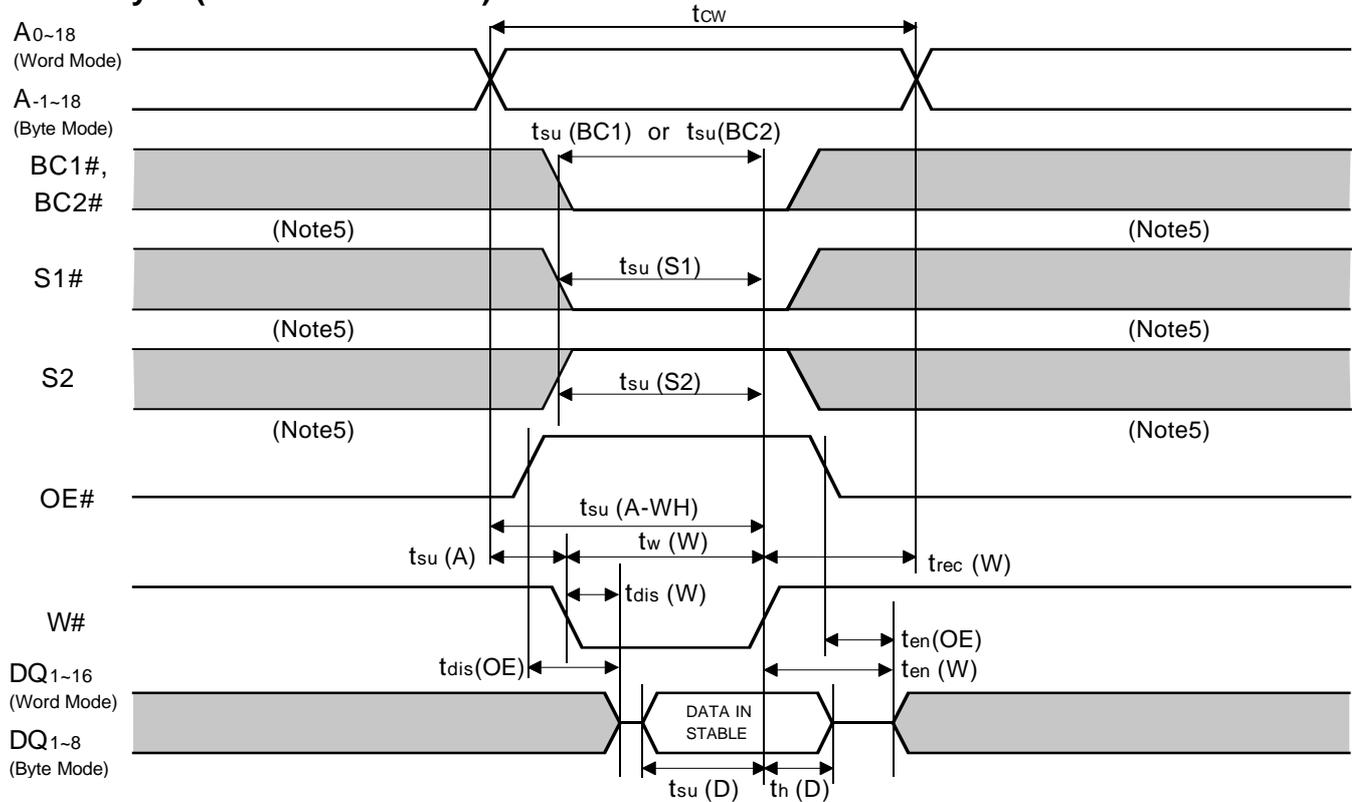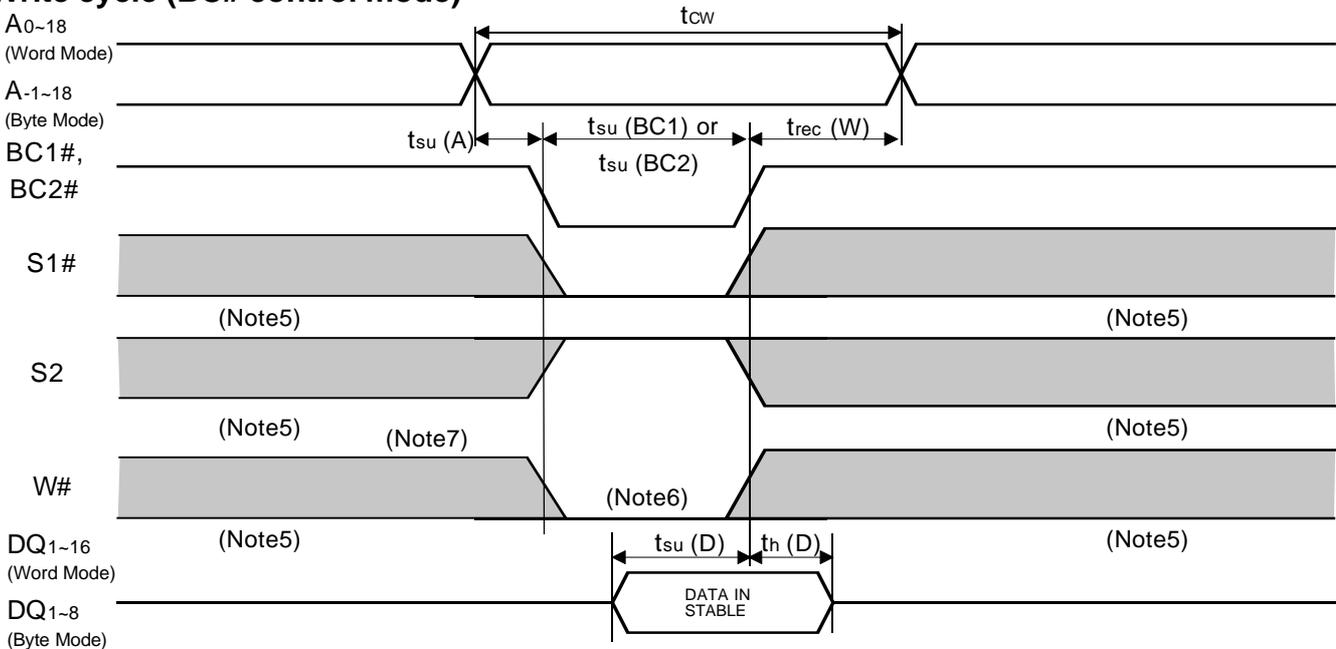
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Write cycle(W# control mode)

Write cycle (BC# control mode)

Note 5: Hatching indicates the state is "don't care".

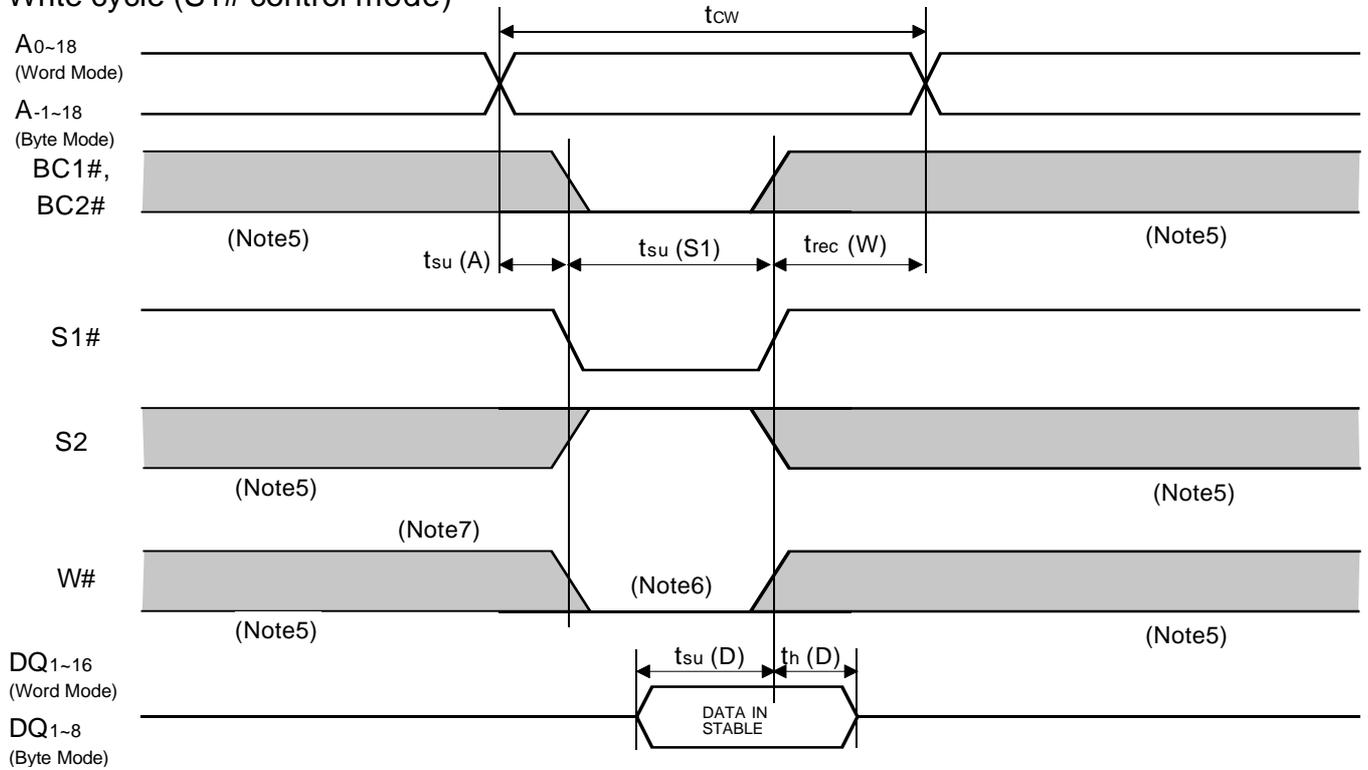Note 6: A Write occurs during S1# low, S2 high ov erlaps BC1# and/or BC2# low and W# low.

Note 7: When the f alling edge of W# is simultaneously or prior to the f alling edge of BC1# and/or BC2# or the f alling edge of S1# or rising edge of S2, the outputs are maintained in the high impedance state.

Note 8: Don't apply inv erted phase signal externally when DQ pin is in output mode.
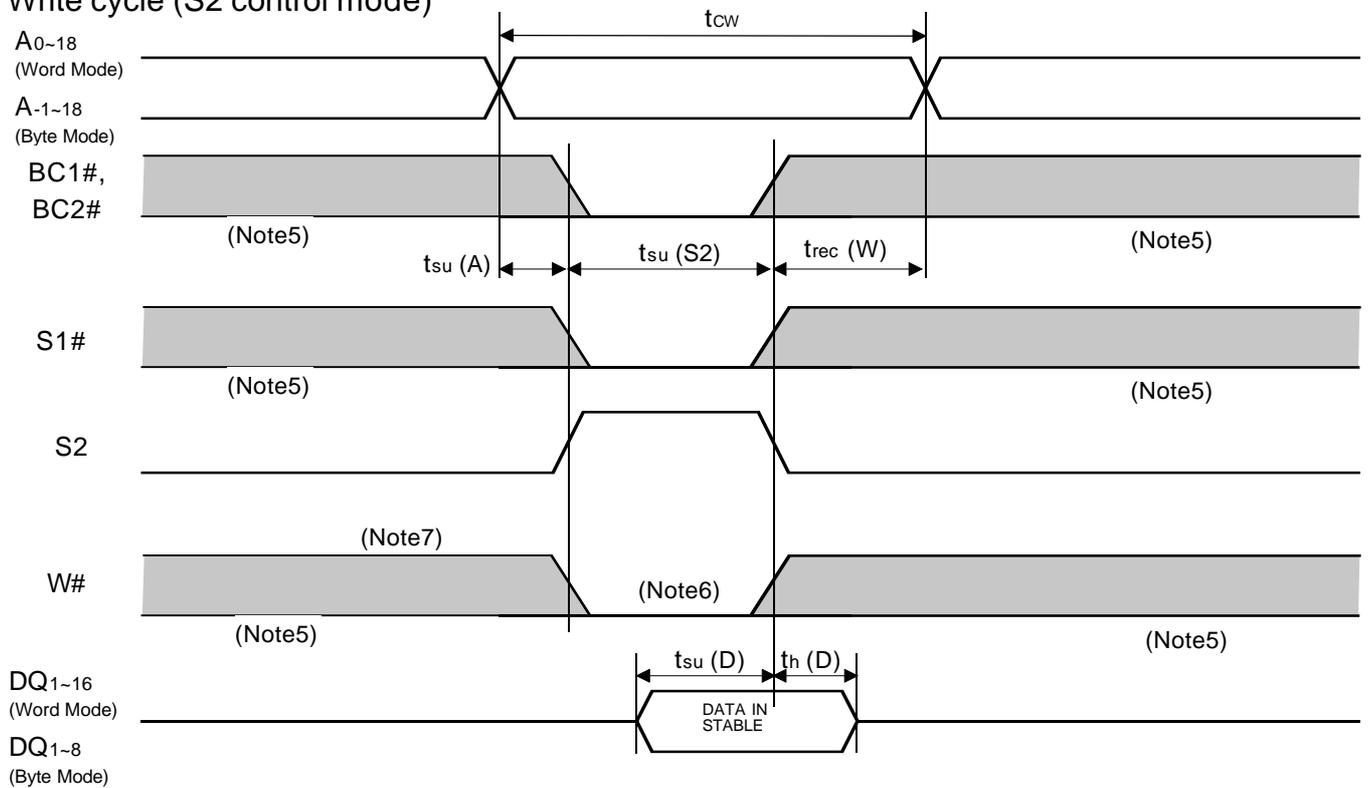
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Write cycle (S1# control mode)

t_{CW}

A$_{0~18}$
(Word Mode)

A$_{-1~18}$
(Byte Mode)

BC1#,
BC2#

(Note5)

t_{su} (A) t_{su} (S1) t_{rec} (W)   (Note5)

S1#

S2

(Note5)   (Note5)

(Note7)

W#   (Note6)

(Note5)   (Note5)

DQ$_{1~16}$
(Word Mode)

t_{su} (D) t_h (D)

DATA IN STABLE

DQ$_{1~8}$
(Byte Mode)

Write cycle (S2 control mode)

t_{CW}

A$_{0~18}$
(Word Mode)

A$_{-1~18}$
(Byte Mode)

BC1#,
BC2#

(Note5)

t_{su} (A) t_{su} (S2) t_{rec} (W)   (Note5)

S1#

(Note5)   (Note5)

S2

(Note7)

W#   (Note6)

(Note5)   (Note5)

DQ$_{1~16}$
(Word Mode)

t_{su} (D) t_h (D)

DATA IN STABLE

DQ$_{1~8}$
(Byte Mode)

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POWER DOWN CHARACTERISTICS
(1) ELECTRICAL CHARACTERISTICS (Ta=-40~85ºC, Vcc=2.7V~3.6V,unless otherwise noted)

Symbol	Parameter	Test conditions		Limits			Units
				Min	Typ	Max	
Vcc (PD)	Power down supply voltage			2.0			V
VI (BC)	Byte control input BC1# & BC2#			2.0			V
VI (S1#)	Chip select input S1#			2.0			V
VI (S2)	Chip select input S2					0.2	
Icc (PD)	Power down supply current	**Vcc=2.0V** (1) S1# $\geq$ Vcc - 0.2V, BYTE# $\geq$ Vcc - 0.2V or $\leq$ 0.2V other inputs = 0 ~ Vcc (2) S2 $\leq$ 0.2V , BYTE# $\geq$ Vcc - 0.2V or $\leq$ 0.2V other inputs = 0 ~ Vcc (3) BC1# and BC2# $\geq$ Vcc - 0.2V S1# $\leq$ 0.2V, S2 $\geq$ Vcc - 0.2V BYTE# $\geq$ Vcc - 0.2V or $\leq$ 0.2V other inputs = 0 ~ Vcc	~ +25°C	-	0.2	3.0	μA
			~ +40°C	-	0.4	6.0	
			~ +70°C	-	-	30	
			~ +85°C	-	-	60	

Note 9: Typical parameter of Icc(PD) indicates the value for the center of distribution at 2.0V, and not 100% tested.

(2) TIMING REQUIREMENTS

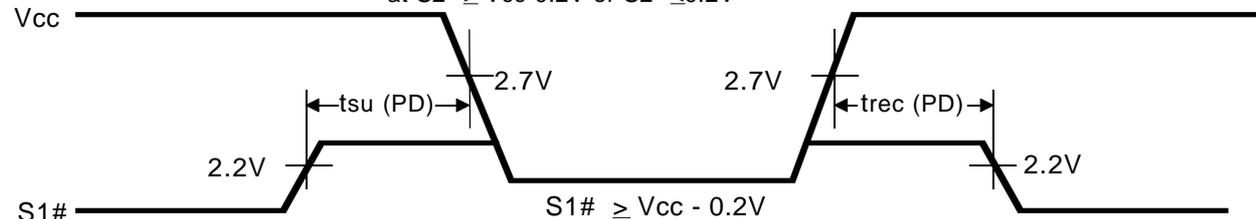| Symbol	Parameter	Test conditions	Limits			Units
			Min	Typ	Max	
tsu (PD)	Power down set up time		0			ns
trec (PD)	Power down recovery time		5			ms

(3) TIMING DIAGRAM

BC# control mode

note10:On the BC# control mode, the level of S1# and S2 must be fixed at S1#, S2 $\geq$ Vcc-0.2V or S2 $\leq$0.2V
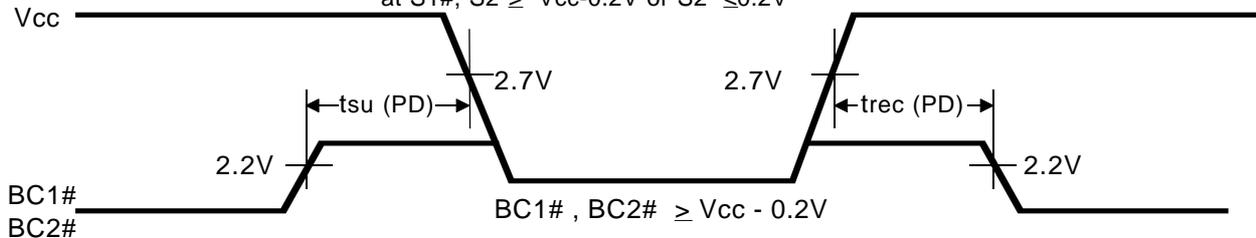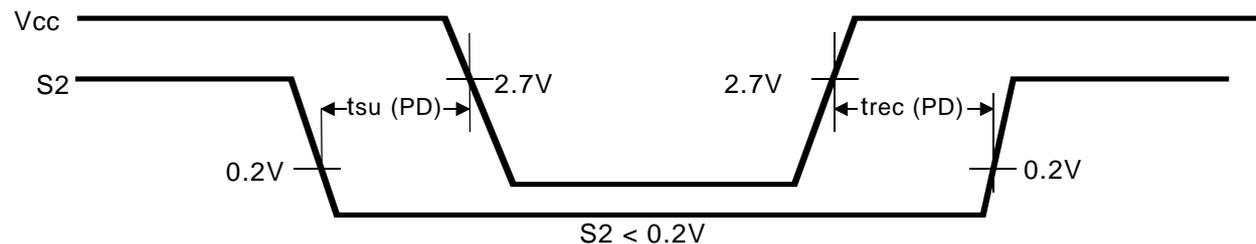

S1# control mode

note11:On the S1# control mode, the level of S2 must be fixed at S2 $\geq$ Vcc-0.2V or S2 $\leq$0.2V

S2 control mode

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Keep safety first in your circuit designs!

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